

MOSFET – Power, Single P-Channel

-60 V, -14 A, 52 mΩ

NVTFS5116PL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFS5116PLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-60	٧
Gate-to-Source Voltage	€		V_{GS}	±20	V
Continuous Drain Current R _{ΨJ-mb}		T _{mb} = 25°C	I _D	-14	Α
(Notes 1, 2, 3, 4)	Steady	T _{mb} = 100°C		-10	
Power Dissipation	State	T _{mb} = 25°C	P_{D}	21	W
$R_{\Psi J-mb}$ (Notes 1, 2, 3)		T _{mb} = 100°C		10	
Continuous Drain		T _A = 25°C	I _D	-6	Α
Current R _{0JA} (Notes 1, 3, 4)	Steady	T _A = 100°C		-4	
Power Dissipation	State	T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	-126	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	-17	Α
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, $I_{L(pk)}$ = 30 A, L = 0.1 mH, I_{RG} = 25 $I_{L(pk)}$			E _{AS}	45	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

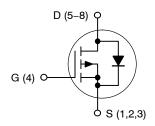
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\PsiJ-mb}$	7.2	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
60.1/	52 mΩ @ –10 V	–14 A
–60 V	72 mΩ @ -4.5 V	-147

P-Channel MOSFET

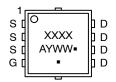






WDFN8 (μ8FL) CASE 511AB WDFNW8 (μ8FL WF) CASE 515AN

MARKING DIAGRAM



XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

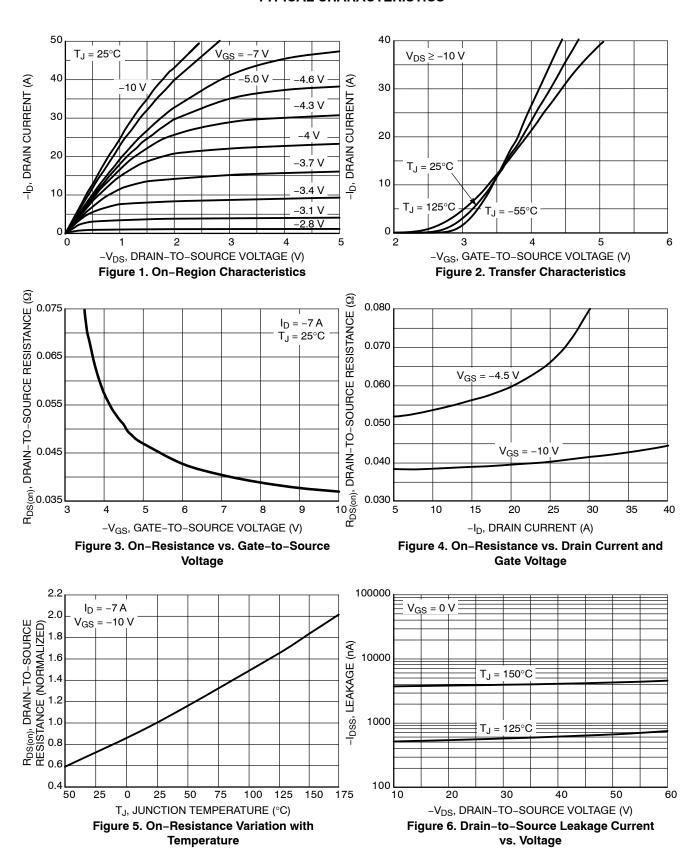
Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							1
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-60			V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$				-1.0	μА
		$V_{DS} = 60 \text{ V}$	T _J = 125°C			-10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = V_{DS}$	= -250 μA	-1		-3	V
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = -10 \text{ V},$	_D = -7 A		37	52	mΩ
		$V_{GS} = -4.5 \text{ V},$	I _D = -7 A		51	72	
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I	_O = -5 A		11		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, } f = 1.0 \text{ MHz,}$ $V_{DS} = -25 \text{ V}$			1258		pF
Output Capacitance	C _{oss}				127		
Reverse Transfer Capacitance	C _{rss}				84		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -48 \text{ V},$ $I_{D} = -7 \text{ A}$			14		nC
Threshold Gate Charge	Q _{G(TH)}				1		
Gate-to-Source Charge	Q_{GS}				4		
Gate-to-Drain Charge	Q_GD				8		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -10 \text{ V}, V_{D}$ $I_{D} = -7$	_S = -48 V, A		25		nC
SWITCHING CHARACTERISTICS (No	te 6)					•	
Turn-On Delay Time	t _{d(on)}				14		ns
Rise Time	t _r	Vcs = -4.5 V. Vr	ne = -48 V.		68		
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = -4.5 \text{ V}, V_{D}$ $I_{D} = -7$	A		24		
Fall Time	t _f				36		
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•	•	•
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = -7 \text{ A}$	T _J = 25°C		-0.79	-1.20	V
		I _S = -7 A	T _J = 125°C		-0.64		
Reverse Recovery Time	t _{RR}		•		21		ns
Charge Time	ta	V _{GS} = 0 V, dI _S /dt	= 100 A/us.		16		1
Discharge Time	t _b	I _S = -7			5		1
Reverse Recovery Charge	Q _{RR}				24		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

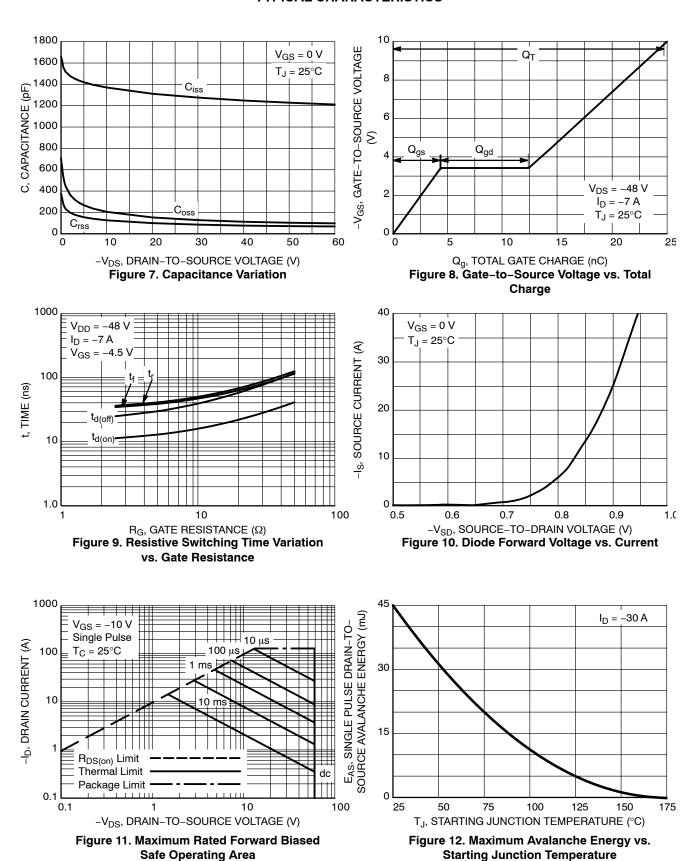
5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

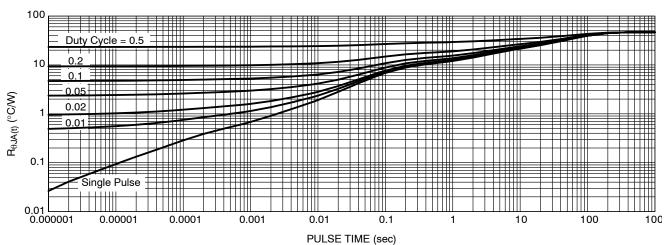


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS5116PLTAG	5116	WDFN8 3.3x3.3, 0.65P (Pb-Free)	1500 / Tape & Reel
NVTFS5116PLWFTAG	16LW	WDFN8 3.3x3.3, 0.65P (Pb-Free)	1500 / Tape & Reel
NVTFS5116PLTWG	5116	WDFN8 3.3x3.3, 0.65P (Pb-Free)	5000 / Tape & Reel
NVTFS5116PLWFTWG	16LW	WDFNW8 3.3x3.3, 0.65P (Full-Cut µ8FL WF) (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



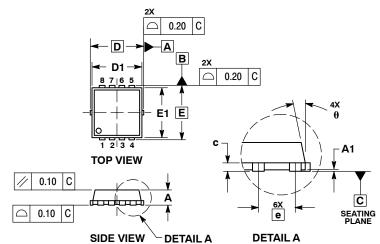




SCALE 2:1

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS		INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC	;	(0.026 BS0)
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

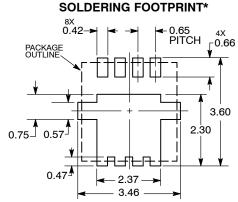


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year = Work Week WW = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

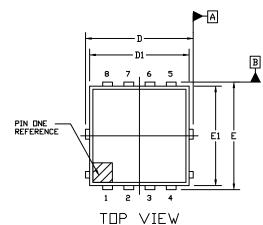
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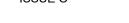
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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.



DATE 25 AUG 2020



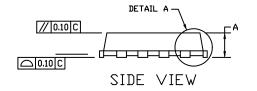


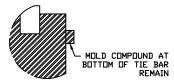
NDTES:

- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

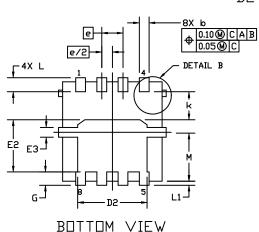
	PLATED AREA
DETAIL	C C SEATING PLANE

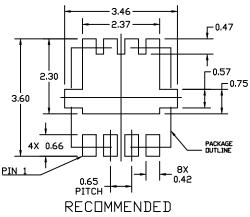
	MILLIMETERS				
DIM	MIN.	NDM.	MAX.		
A	0.70	0.75	0.80		
A1	0.00		0.05		
ø	0.23	0.30	0.40		
n	0.15	0.20	0.25		
D	3.05	3.30	3.55		
D1	2.95	3.05	3.15		
D2	1.98	2.11	2.24		
Ε	3.05	3.30	3.55		
E1	2.95	3.05	3.15		
E2	1.47	1.60	1.73		
E3	0.23	0.30	0.40		
a		0.65 BSC			
G	0.30	0.41	0.51		
K	0.65	0.80	0.95		
٦	0.30	0.43	0.59		
L1	0.06	0.13	0.20		
М	1.40	1.50	1.60		





DETAIL B





MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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